

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/564,249	MIYAWAKI ET AL.		
Examiner	Art Unit		
Megann E. Vaughn	2859		

	SEARCHED				
Class	Subclass	Date	Examiner		
324	320	7/22/2007	MV		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
see attached EAST Search History	· 7/22/2007	MV		